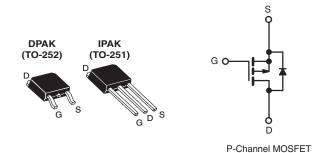




Vishay Siliconix

### Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	- 50				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = - 10 V	0.50			
Q <sub>g</sub> (Max.) (nC)	9.1				
Q <sub>gs</sub> (nC)	3.0				
Q <sub>gd</sub> (nC)	5.9				
Configuration	Single				



#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mountable (Order as IRFR9010, SiHFR9010)
  Straight Lead Option (Order as IRFU9010, SiHFU9010)
  RoHS
- Repetitive Avalanche Ratings
- Dynamic dV/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT **HALOGEN** FREE

### **DESCRIPTION**

The Power MOSFET technology is the key to Vishay's advanced line of Power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery dV/dt capability.
The Power MOSFET transistors also feature all of the well

established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

Surface mount packages enhance circuit performance by reducing stray inductances and capacitance. The DPAK (TO-252) surface mount package brings the advantages of Power MOSFETs to high volume applications where PC Board surface mounting is desirable. The surface mount option IRFR9010, SiHFR9010 is provided on 16 mm tape. The straight lead option IRFU9010, SiHFU9010 of the device is called the IPAK (TO-251).

They are well suited for applications where limited heat dissipation is required such as, computers and peripherals, telecommunication equipment, dc-to-dc converters, and a wide range of consumer products.

ORDERING INFORMATION							
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)			
Lead (Pb)-free and Halogen-free	SiHFR9010-GE3	SiHFR9010TR-GE3a	SiHFR9010TRL-GE3a	SiHFU9010-GE3			
Lead (Pb)-free	IRFR9010PbF	IRFR9010TRPbFa	IRFR9010TRLPbFa	IRFU9010PbF			
	SiHFR9010-E3	SiHFR9010T-E3a	SiHFR9010TL-E3a	SiHFU9010-E3			
SnPb	IRFR9010	IRFR9010TR <sup>a</sup>	IRFR9010TRL <sup>a</sup>	IRFU9010			
	SiHFR9010	SiHFR9010Ta	SiHFR9010TLa	SiHFU9010			

#### Note

See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS</b> T <sub>C</sub> = 25 °C, unless otherwise noted						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	$V_{DS}$	- 50	V			
Gate-Source Voltage	V <sub>GS</sub>	± 20				
Continuous Drain Current	$V_{GS}$ at - 10 V $\frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$		- 5.3	А		
Continuous Drain Current	$T_{\rm C} = 100  ^{\circ}{\rm C}$		- 3.3			
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	- 21			
Linear Derating Factor			0.20	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	136	mJ		
Repetitive Avalanche Currenta		I <sub>AR</sub>	- 5.3	Α		
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	2.5	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	$P_{D}$	25	W		
Peak Diode Recovery dV/dtc		dV/dt	5.8	V/ns		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)d	for 10 s		300			

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14). b.  $V_{DD} = -25$  V, starting  $T_J = 25$  °C, L = 9.7 mH,  $R_g = 25$   $\Omega$ , peak  $I_L = -5.3$  A. c.  $I_{SD} \le -5.3$  A,  $I_{SD} \le -5.3$

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFR9010, IRFU9010, SiHFR9010, SiHFU9010

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110	
Case-to-Sink	R <sub>thCS</sub>	-	1.7	-	°C/W
Maximum Junction-to-Case (Drain)a	R <sub>thJC</sub>	-	-	5.0	

#### Note

a. Mounting pad must cover heatsink surface area.

PARAMETER	SYMBOL	Т	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	V <sub>G</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA		-	-	V
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub>	<sub>S</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 500	nA
Zono Coto Voltago Duois Current	1	V <sub>DS</sub> =	max. rating, V <sub>GS</sub> = 0 V	-	-	- 250	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 0.8 \text{ x m}$	ax. rating, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	- 1000	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 2.8 A <sup>b</sup>	-	0.35	0.5	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	≤ - 50 V, I <sub>DS</sub> = - 2.8 A	1.1	1.7	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	240	-	
Output Capacitance	C <sub>oss</sub>	] .	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0  MHz,  see fig. 9		160	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	T =			30	-	
Total Gate Charge	Qg		$I_D = -4.7 \text{ A}, V_{DS} = 0.8 \text{ x max}.$	-	6.1	9.1	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = - 10 V	rating, see fig. 16 (Independent operating	-	2.0	3.0	
Gate-Drain Charge	$Q_{gd}$		temperature)	-	3.9	5.9	
Turn-On Delay Time	t <sub>d(on)</sub>				6.1	9.2	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 25 V, $I_{D}$ = - 4.7 A, $R_{g}$ = 24 $\Omega$ , $R_{D}$ = 5.6 $\Omega$ , see fig. 15 (Independent operating temperature)		-	47	71	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	13	20	
Fall Time	t <sub>f</sub>				35	59	
Internal Drain Inductance	L <sub>D</sub>	6 mm (0.25	Between lead, 6 mm (0.25") from package and center of die contact.		4.5	-	nH
Internal Source Inductance	L <sub>S</sub>				7.5	-	ПΠ
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the	MOSFET symbol showing the integral reverse p - n junction diode		-	- 5.3	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	_			_	- 18	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °	T <sub>J</sub> = 25 °C, I <sub>S</sub> = - 5.3 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	- 5.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T _ 25 °C	T 05 00 1 4.7 A 41/44 400 A / sh		75	160	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = -4.7  \text{A},  \text{dI/dt} = 100  \text{A/} \mu \text{s}^{\text{b}}$		0.090	0.22	0.52	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_I$				L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

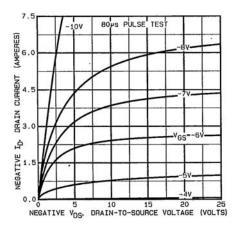


Fig. 1 - Typical Output Characteristics

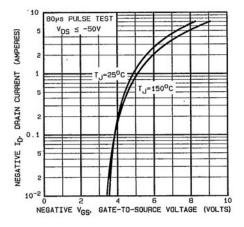


Fig. 2 - Typical Transfer Characteristics

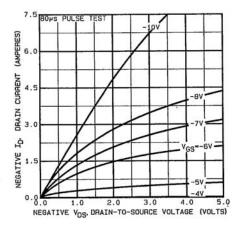


Fig. 3 - Typical Saturation Characteristics

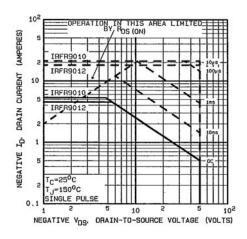


Fig. 4 - Maximum Safe Operating Area

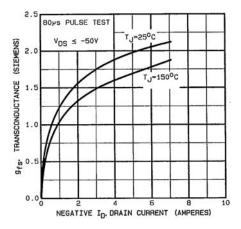


Fig. 5 - Typical Transconductance vs. Drain Current

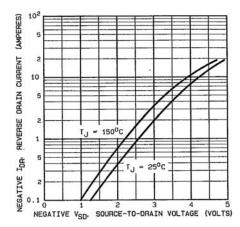


Fig. 6 - Typical Source-Drain Diode Forward Voltage

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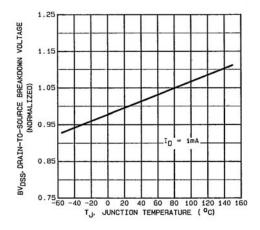


Fig. 7 - Breakdown Voltage vs. Temperature

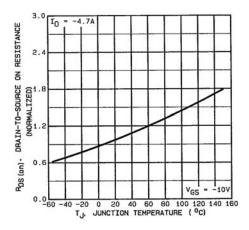


Fig. 8 - Normalized On-Resistance vs. Temperature

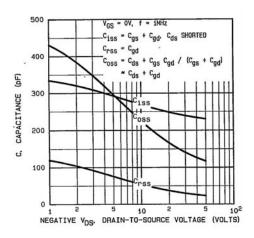


Fig. 9 - Typical Capacitance vs. Drain-to-Source Voltage

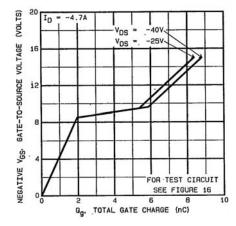


Fig. 10 - Typical Gate Charge vs. Gate-to-Source Voltage



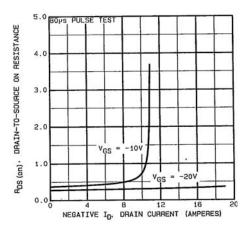


Fig. 11 - Typical On-Resistance vs. Drain Current

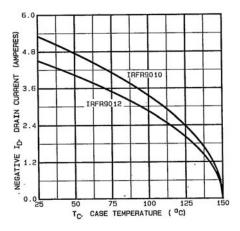


Fig. 12 - Maximum Drain Current vs. Case Temperature

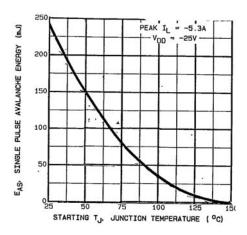


Fig. 13a - Maximum Avalanche vs. Starting Junction Temperature

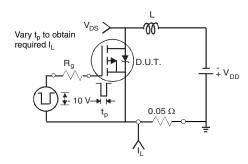


Fig. 13b - Unclamped Inductive Test Circuit

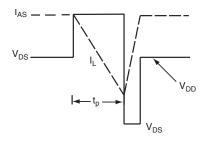


Fig. 13c - Unclamped Inductive Waveforms

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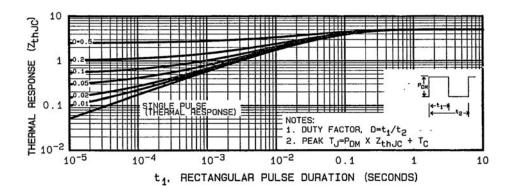


Fig. 14 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration

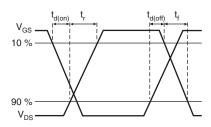


Fig. 15a - Switching Time Waveforms

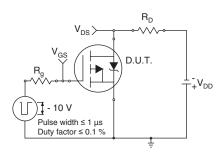


Fig. 15b - Switching Time Test Circuit

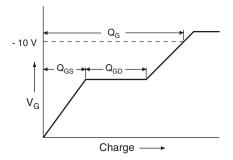


Fig. 16a - Basic Gate Charge Waveform

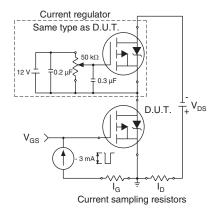
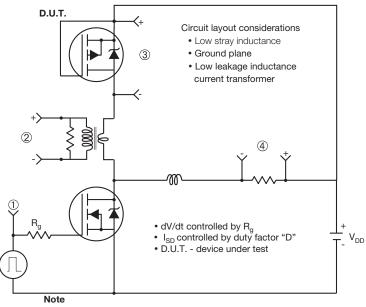


Fig. 16b - Gate Charge Test Circuit

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#### Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

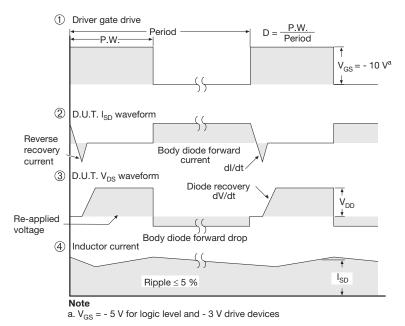


Fig. 17 - For P-Channel

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